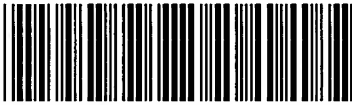


Search Notes



Application/Control No.

10/773,366

Examiner

John S. Chu

Applicant(s)/Patent under Reexamination

SAITO ET AL.

Art Unit

1752

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|--------|----------|
| 430 | 157 | 7/2007 | JSC |
| 430 | 171 | ↓ | ↓ |
| 430 | 182 | ↓ | ↓ |
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INTERFERENCE SEARCHED

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| 430 | 157,171 | 7/2007 | JSC |
| 430 | 182 | ↓ | ↓ |
| 548 | 146 | ↓ | ↓ |
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)

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